## Notice of References Cited Application/Control No. 10/629,806 Examiner Sin J. Lee Applicant(s)/Patent Under Reexamination KOZAWA ET AL. Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,329,119 B1	12-2001	Suetsugu et al.	430/270.1
	В	US-6,416,939 B1	07-2002	Shimada et al.	430/325
	C	US-6,048,637	04-2000	Tsukahara et al.	429/53
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

_									
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U								
	>								
	w								
	x								

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.